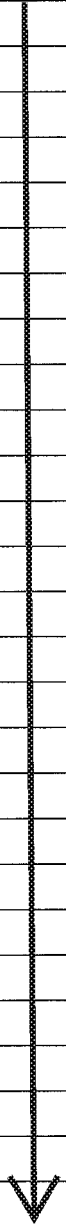


<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	Application No.	10/506,361
	Filing Date	May 16, 2005
	First Named Inventor	Weh et al.
	Art Unit	3679
(Multiple sheets used when necessary)	Examiner	Jay R. Ripley
SHEET 1 OF 2	Attorney Docket No.	JFIE5.004APC

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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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Examiner Signature	Date Considered
<p><b>*Examiner:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>	

T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.

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SHEET 2 OF 2		Attorney Docket No.	JFIE5.004APC

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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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